Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/848,952	LURIE ET AL.	
Examiner	Art Unit	_
J. Derek Rutten	2192	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	6/19/2006	JDR
717/104,174; 707/10,103; 703 Text search only. See search history printout	6/19/2006	JDR
Will Grant (consulted re. 101)	7/27/2006	JDR
717/104-105; 707/10 Text search only. See search history printout	7/27/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	7/27/2006	JDR
717/104-105; 707/10 Text search only. See search history printout	7/28/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	7/28/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history	8/1/2006	JDR

Search Notes (continued)

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	DATE	EXMR
Google - www.google.com Google Scholar - scholar.google.com ACM - portal.acm.org See search history printout	7/27/2006	JDR
Google - www.google.com See search history printout	7/28/2006	JDR
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